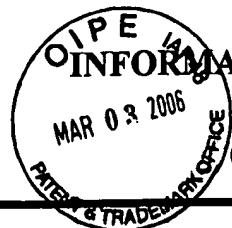


Form PTO-1449



(Use several sheets if necessary)

Attorney Docket No.
150-PDD-00-14DIVSerial No.
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U.S. PATENT DOCUMENTS

Examiner Initials	Item	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
NRP	A	4,467,802	8-28-84	Maslanka	128	321	1-27-82
	B	5,667,525	9-16-97	Ishibashi	606	206	7-20-95
	C	5,944,728	8-31-99	Bates	606	127	4-23-98
	D	5,971,938	10-26-99	Hart, et al.	600	562	11-19-97
	E	6,077,274	6-20-00	Ouchi, et al.	606	113	9-8-98
	F	6,174,318	1-16-01	Bates, et al.	606	127	4-23-98
	G	6,280,451	8-28-01	Bates, et al.	606	127	5-24-00
	H	6,497,709	12-24-02	Heath	606	127	5-5-97
	I	6,652,537	11-25-03	Mercereau, et al.	606	127	12-12-01
	J	6,676,668	1-13-04	Mercereau, et al.	606	127	12-12-01
	K	6,679,893	1-20-04	Tran	606	127	11-16-00
	L	6,899,721	5-31-05	Sferco	606	205	4-19-02
	M	2001/0041899	11-15-01	Foster	606	127	3-26-99
	N	2003/0135233	7-17-03	Bates, et al.	606	200	2-3-03
	O	2004/0097964	5-20-04	Dhindsa	606	127	9-17-03
	P	2004/0133213	7-8-04	Bagley, et al.	606	127	12-12-03
	Q	2004/0215212	10-28-04	Teague, et al.	606	127	4-24-03
↓	R	2005/0049613	3-3-05	Brown	606	127	6-25-04

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		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
NRP	S	WO 94/20029	9-15-94	PCT			X	
	T	WO 97/38632	10-23-97	PCT			X	
	U	WO 96/23446	8-8-96	PCT			X	
	V	JP2005052668	3-3-05	Japan			X	
	W	JP2004105727	4-5-04	Japan			X	
	X	JPS111493	5-7-93	Japan			X	
↓	Y	JP6154231	6-3-94	Japan			X	

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